

Search Notes

Application/Control No.

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Examiner

Annan Q. Shang

Applicant(s)/Patent under
Reexamination

SATO ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
725	1- 8,68,100,1 31,139,14 1,151	1/31/2006	A.S

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR